

Dual N-Channel Enhancement Mode Field Effect Transistor with Schottky Diode

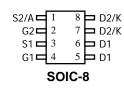
PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)			
30	0.008 at V _{GS} = 10 V	8	15 nC			
30	0.012 at V _{GS} = 4.5 V	6.8	15110			

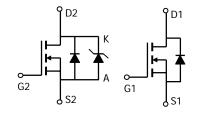
FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % UIS Tested
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Set Top Box
- Low Current DC/DC





Absolute Maximum Ratings T _A =25°C unl	ess otherwi	se noted			
Parameter		Symbol	MOSFET	Schottky	Units
Drain-Source Voltage		V _{DS}	30		V
Gate-Source Voltage		V_{GS}	±12		V
	T _A =25°C	1	8		
Continuous Drain Current ^A	T _A =70°C	I _D	6.8		A
Pulsed Drain Current ^B		I _{DM}	40		
Schottky reverse voltage		V _{KA}		30	V
	T _A =25°C	I _F		3	
Continuous Forward Current ^A	T _A =70°C	۴.		2	A
Pulsed Forward Current ^B		I _{FM}		40	1
	T _A =25°C	р	2	2	W
Power Dissipation	T _A =70°C	P _D	1.44	1.44	~ ~
Junction and Storage Temperature Range	-	T _J , T _{STG}	-55 to 150	-55 to 150	°C
Parameter: Thermal Characteristics MOS	SFET	Symbol	Typ	Max	Unit

Parameter: Thermal Characteris	Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient ^A	t ≤ 10s	– R _{eja}	48	62.5		
Maximum Junction-to-Ambient ^A	Steady-State	ιν _θ JΑ	74	110	°C/W	
Maximum Junction-to-Lead ^C	Steady-State	$R_{ ext{ ext{ ext{ ext{ ext{ ext{ ext{ ext$	35	40		
Thermal Characteristics Schottky						
Maximum Junction-to-Ambient ^A	t ≤ 10s	R _{0JA}	47.5	62.5		
Maximum Junction-to-Ambient ^A	Steady-State	I ∿ ⊕JA	71	110	°C/W	
Maximum Junction-to-Lead ^C	Steady-State	$R_{ ext{ hetaJL}}$	32	40		



COMPLIANT HALOGEN

FREE

服务热线:400-655-8788



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			•				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		32			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		- 5.0		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.0		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1		
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5$ V, V_{GS} = 10 V	10			Α	
		V _{GS} = 10 V, I _D = 5 A		0.008		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 4 A		0.012			
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 5 A		16		S	
Dynamic ^b							
Input Capacitance	C _{iss}			586		pF	
Output Capacitance	C _{oss}	V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz		117			
Reverse Transfer Capacitance	C _{rss}			55			
Total Gate Charge	0	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 5 \text{ A}$		15			
	Qg			3.7	5.6	nC	
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 5 A		1.4			
Gate-Drain Charge	Q _{gd}			1.05			
Gate Resistance	R _g	f = 1 MHz	0.8	4.3	8.6	Ω	
Turn-On Delay Time	t _{d(on)}			12	24		
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		55	100	1	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 5 A, V_GEN = 4.5 V, R_g = 1 Ω		11	22		
Fall Time	t _f			8	16		
Turn-On Delay Time	t _{d(on)}			4	8	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		9	18	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 5 A, V_{GEN} = 10 V, R_g = 1 Ω		10	20		
Fall Time	t _f			6	12		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			2.25	٨	
Pulse Diode Forward Current	I _{SM}				24	A	
Body Diode Voltage	V _{SD}	$I_{S} = 2 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			11	20	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$L = 5.0 dt/dt = 100.0 t_{10} T = 25.00$		4	8	nC	
Reverse Recovery Fall Time	ta	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		7			
Reverse Recovery Rise Time	t _b	-		4		ns	

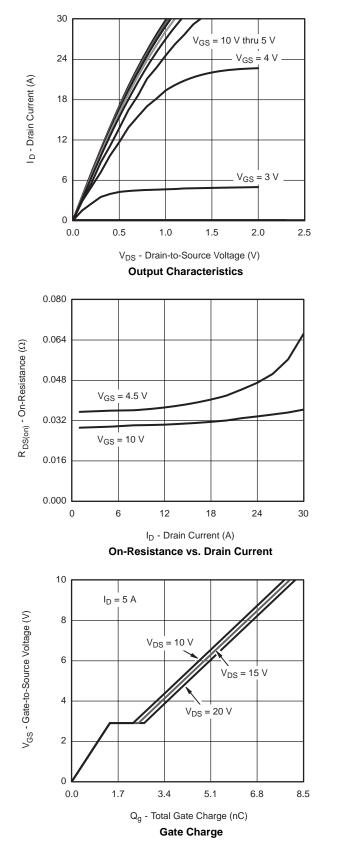
Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

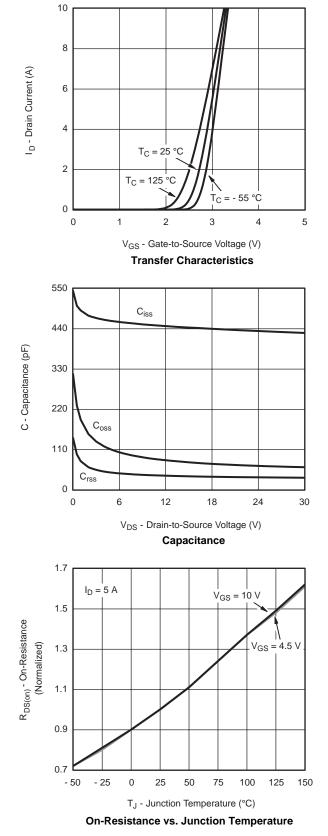
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





 $I_D = 5 A$

T_J = 125 °C

T_J = 25 °C

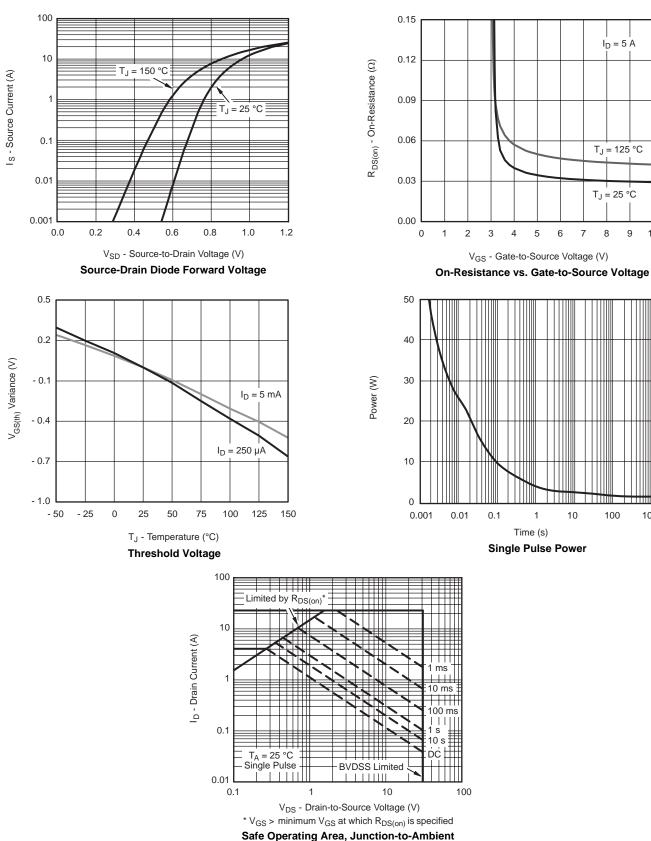
8 9 10

6 7

10

100

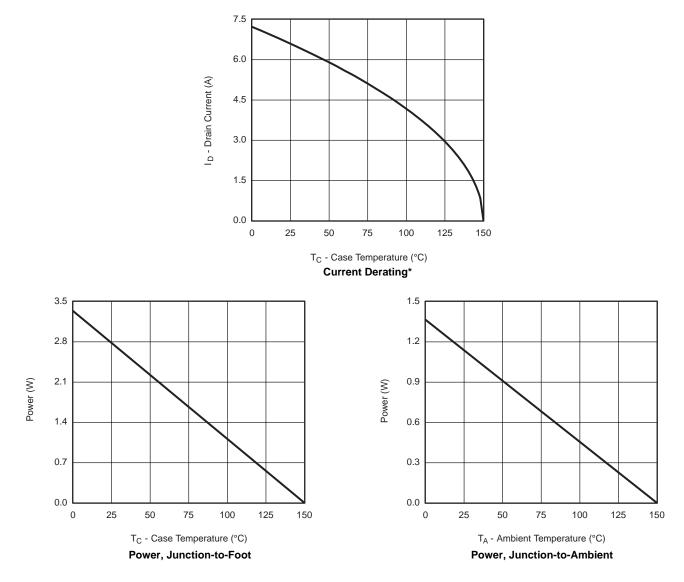
1000



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



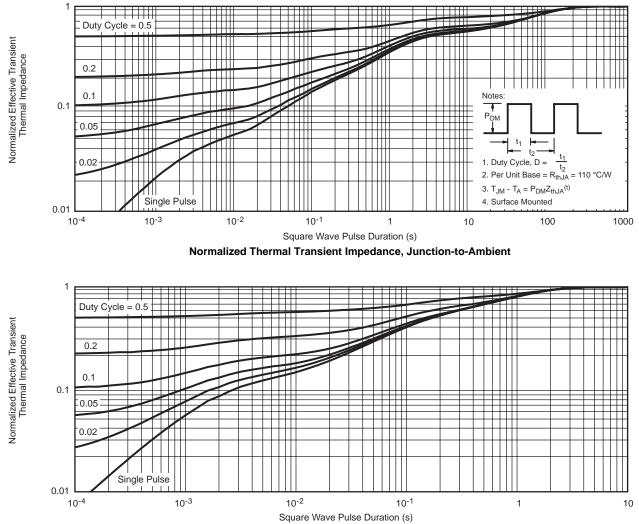
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

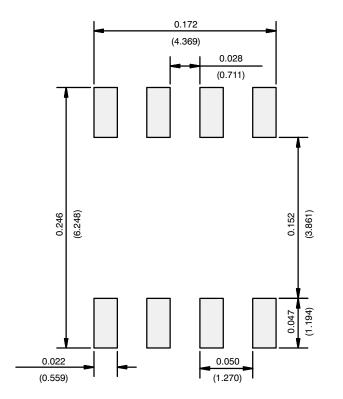




	MILLIMETERS		INC	HES		
DIM	Min	Max	Min	Max		
A	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050	BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498						



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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